Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,110	PAILA ET AL.	
Examiner	Art Unit	
Meless N. Zewdu	2617	

	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
EXMR				
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